

Application/Control No.	Applicant(s)/Paten Reexamination	Applicant(s)/Patent under Reexamination	
10/500,173	TAKAHASHI ET AL.		
Examiner	Art Unit		
Ileana Popa	1633		

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

(INCLUDING SEARC	H STRATEGY	)
	DATE	EXMR
Double patetning, West, Palm inventors.	12/23/2007	ΙP